

Identification of oxygen vacancy types from Raman spectra of SnO₂ nanocrystals

L. Z. Liu,^a T. H. Li,^{a,b} X. L. Wu,^{a*} J. C. Shen^a and P. K. Chu^c



Raman spectra acquired from spherical SnO₂ nanocrystals prepared by pulsed laser ablation and hydrothermal synthesis exhibit three oxygen-vacancy-related Raman modes at 234, 573, and 618 cm⁻¹. The peak location and intensity vary with annealing temperature under O₂ finally approaching those of bulk materials. Density functional calculation discloses that the three Raman modes stem from subbridging, in-plane, and bridging oxygen vacancies, respectively. Raman spectra can thus be used to discern different types of oxygen vacancies in SnO₂ nanocrystals. Copyright © 2012 John Wiley & Sons, Ltd.

Supporting Information may be found in the online version of this article.

Keywords: SnO₂ nanocrystals; Raman spectroscopy; oxygen vacancies; annealing processing; density functional calculation

Introduction

Tin oxide (SnO₂) is one of the attractive functional materials because of potential applications to biophysics, gas sensing, catalysis, and batteries.^[1–6] SnO₂ nanostructures with different morphologies such as nanowires (nanorods),^[7] nanoribbons (nanobelts),^[8,9] and nanocrystals (NCs)^[10,11] exhibit some novel characteristics. Because oxygen vacancies (OVs) play a critical role in many of the new physical phenomena,^[9,12,13] more accurate identification and better understanding of the different OV structures are of fundamental and technical interest. SnO₂ has a tetragonal rutile structure (space group D_{4h}^{14} , $P42/mnm$) with two molecules per unit cell. The irreducible representation of optic modes is $\Gamma = A_{1g} + A_{2g} + B_{1g} + B_{2g} + E_g + A_{2u} + 2B_{1u} + 3E_u$.^[14] The A_{2g} and $2B_{1u}$ modes are neither Raman active nor infrared (IR) active. The symmetrical A_{2u} and E_u modes are IR active, whereas the remaining A_{1g} , B_{1g} , B_{2g} , and E_g modes are Raman active. Raman scattering is a useful tool to identify microstructural changes, and our previous investigations revealed that the Raman mode at ~574 cm⁻¹ was closely associated with the in-plane OVs in SnO₂ NCs.^[13] The findings suggest that it is possible to correlate the different Raman modes with OV types (bridging and subbridging) and that Raman scattering can be employed to identify the types of OVs and to explore the physical mechanism.

In this work, the Raman spectra acquired from SnO₂ NCs fabricated by pulsed laser ablation are studied systematically. The IR active mode at ~234 cm⁻¹ is found to transform into a Raman active mode because of relaxation of the $k=0$ selection rule induced by subbridging OV. Meanwhile, the existence of bridging OVs downshifts the A_{1g} mode at ~635 to ~618 cm⁻¹. To investigate the underlying mechanism, the density functional theory (DFT) is adopted to derive the Raman spectra of SnO₂ NCs with different OV types, and the results indicate that the 234, 573, and 618 cm⁻¹ Raman modes can be used as a fingerprint to identify the types of OVs in SnO₂ nanostructures.

Samples and experiments

Pulsed laser ablation was conducted in water with tin (99.99%) being the target to prepare the SnO₂ NC samples. The detailed experimental setup has been described previously.^[15] After drying, the white powders were annealed at temperatures T_a of 400, 600, 800, and 1000 °C for 6 h under both oxygen and vacuum. The preparation conditions of the samples for both pulsed laser ablation and hydrothermal synthesis are listed in Table S1 (Supporting Information) for comparison. The samples were examined by high-resolution transmission electron microscopy (HR-TEM, JEOL-2100) and X-ray diffraction (XRD) (Philips X' Per Pro X-ray diffractometer). The Raman scattering spectra were obtained on a T64000 triple monochromator Raman system with the 514.5-nm line of an argon ion laser as the excitation source without the polarization configuration. The resolution of the spectrometer was 0.5 cm⁻¹. The diameter of the beam spot was 5 μm, and the power on the samples was less than 4 mW to avoid sample degradation due to laser heating.

Results and discussion

The HR-TEM image in Fig. 1(a) depicts the morphology of the SnO₂ NCs in the sample without any post-treatment. They have

* Correspondence to: Wu, XL, Nanjing National Laboratory of Microstructures and Department of Physics, Nanjing University, Nanjing 210093, China. E-mail: hxlwu@nju.edu.cn

a Nanjing National Laboratory of Microstructures and Department of Physics, Nanjing University, Nanjing 210093, China

b College of Electronic Engineering, Guangxi Normal University, Guilin 541004, China

c Department of Physics and Materials Science, City University of Hong Kong, Tat Chee Avenue, Kowloon, Hong Kong, China

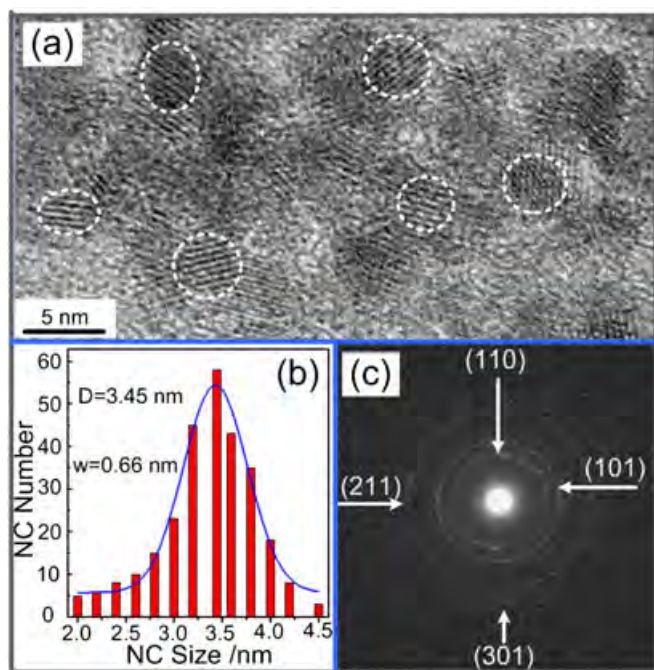


Figure 1. (a) HR-TEM image of the SnO₂ NC sample fabricated by pulsed laser ablation without any post-processing. (b) Size distribution of the SnO₂ NCs calculated from HR-TEM results. (c) SAED pattern of the SnO₂ NCs.

an almost spherical morphology to attain minimum surface free energy. The lattice fringes of 0.343 and 0.265 nm correspond to the (110) and (101) planes of crystalline SnO₂. The Gaussian fit of the SnO₂ NC size distribution is shown in Fig. 1(b) with the probable size and half-width being 3.45 and 0.66 nm. The selected-area electron diffraction (SAED) pattern is displayed in Fig. 1(c), and the three diffraction rings (from inner to outer) are associated with the (110), (101), and (211) planes of rutile SnO₂.

The XRD spectra of the SnO₂ NC samples annealed in O₂ at different T_a are shown in Fig. 2(a). The scan rate of the XRD pattern is 0.25°/s. All the diffraction peaks [(110), (101), and (211)] can be

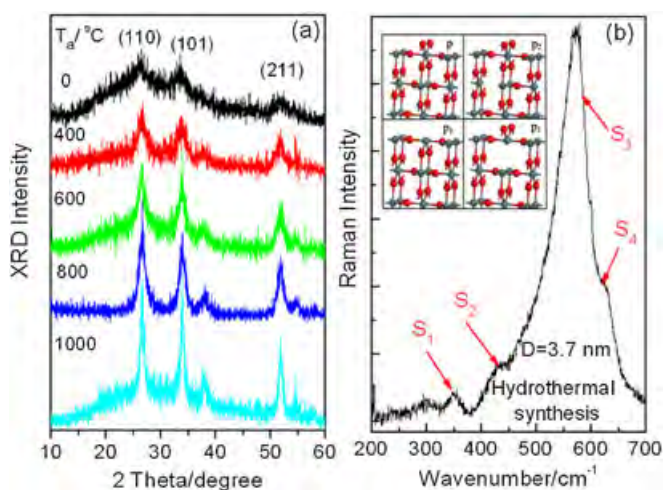


Figure 2. (a) XRD patterns acquired from the SnO₂ NC samples annealed at $T_a = 0, 400, 600, 800,$ and $1000\text{ }^\circ\text{C}$ for 6 h under oxygen. (b) Raman spectrum acquired from the spherical SnO₂ NCs with a diameter of 3.7 nm produced hydrothermally. The inset displays the structural schematic diagram used in the DFT calculation for the SnO₂ (110) surface containing different types of OVs – P: without OV; P₁: bridging OV; P₂: in-plane OV; P₃: subbridging OV. Big and small balls represent Sn and O atoms, respectively.

indexed to the crystalline SnO₂ growth planes. As T_a is increased, the diffraction peaks become sharper and stronger indicating that the particles become bigger and the crystal quality is improved. The Scherrer formula is employed to calculate the average size of the SnO₂ NCs. As T_a is increased, the average sizes increase from 3.5 (the as-made) to 5.5 (400 °C), 6.4 (600 °C), 6.9 (800 °C), and 10.4 nm (1000 °C). Because the XRD patterns acquired from the samples annealed in vacuum are similar to those from the samples annealed in O₂, we infer that the SnO₂ NCs with similar sizes can be obtained in the samples with annealing treatment in vacuum. The Raman spectrum acquired from a SnO₂ NC sample fabricated hydrothermally is also shown in Fig. 2(b) for comparison, and the average size of the NCs is about 3.7 nm as determined by TEM. In addition to the E_u LO mode (S₁) at 353.5 cm⁻¹, E_g mode (S₂) at 430.5 cm⁻¹, and A_{1g} mode (S₄) at 630.0 cm⁻¹, which are related to the small size effect according to Matossi force constant model,^[6,16] a strong mode appears at 573.5 cm⁻¹ (S₃). This mode has been identified to arise from in-plane OVs.^[13]

It is known that the types of OVs can be controlled by adopting different fabrication methods and conditions. Here, pulsed laser ablation is utilized to fabricate SnO₂ nanostructures that possibly contain subbridging and bridging OVs. Figure 3(a) shows the representative Raman spectra acquired from the SnO₂ NC samples annealed under oxygen at different T_a . Three weak peaks at 475.5 (f₅), 540.5 (f₃), and 498.5 cm⁻¹ (f₂) correspond to the B_{1u(2)}, B_{1u(3)}, and E_g modes of crystal SnO₂, respectively,^[14] and the slight shifts can be attributed to the OV-induced phonon confinement effect. At $T_a = 400\text{ }^\circ\text{C}$, the f₄ mode (A_{1g}) wavenumber (at ~619.5 cm⁻¹) and intensity only change slightly compared with those in the unannealed sample, but the intensity of the f₁ mode (E_u TO at ~234.5 cm⁻¹) decreases rapidly. Factor-group analysis indicates that this mode is an IR active mode and it should not appear in the Raman spectrum.^[14] However, Abello *et al.*^[17] have suggested relaxation of the $k = 0$ selection rule because the perfect crystal is destroyed by the existence of OVs leading the IR to Raman transformation. Die'guez *et al.*^[18] have also reported that the SnO₂ nanoparticle surface region is usually covered by a disorder layer containing OVs, and this provides a reasonable explanation of the origin of this mode. At $T_a = 600$ and 800 °C, the Raman spectra of mode f₁ are only slightly modified, but the mode f₄ wavenumber

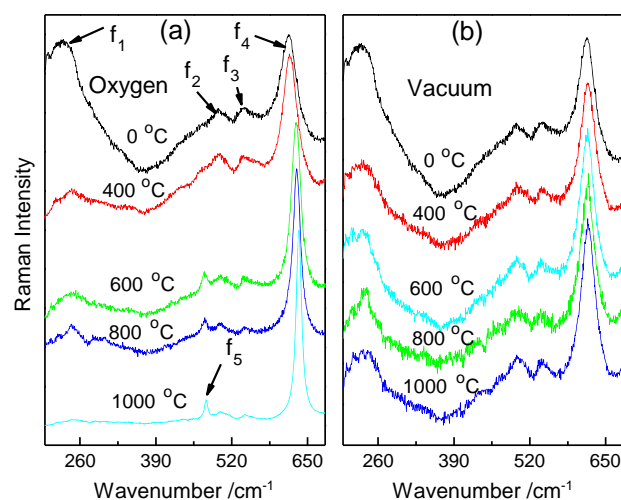


Figure 3. Raman spectra acquired from SnO₂ NC samples annealed at $T_a = 0, 400, 600, 800,$ and $1000\text{ }^\circ\text{C}$ under (a) oxygen and (b) vacuum.

up-shifts significantly to 631.0 cm⁻¹ (bulk) and the intensity is also enhanced. Disappearance of the weak peak (*f*₁) at *T*_a = 1000 °C implies that the OV_s are finally removed by high-temperature annealing. The results provide evidence that the *f*₁ and *f*₄ modes are closely related to OV_s.

Campbell and Fauchet's phonon confinement model is used to explain the *f*₄ mode wavenumber shift.^[19,20] When the NC size increases from 5.5 to 10.3 nm, our calculation shows that the wavenumber only shifts from 628.1 to 632.3 cm⁻¹. Therefore, it can be inferred that the size change is not the main reason for the *f*₄ mode shift. On the basis of the origin of mode *f*₁, mode *f*₄ should also be related to the OV_s in the NCs. However, an obvious shift in the *f*₄ mode can be observed at *T*_a = 600 °C, implying that the *f*₄ mode depends on other types of OV_s compared with the *f*₁ mode. According to the atom displacements model diagram,^[14] the physical origins of the *f*₁ and *f*₄ modes can be ascribed to the subbridging and bridging OV types, respectively. For confirmation, the samples are also annealed in vacuum, and the corresponding Raman spectra are shown in Fig. 3(b). The Raman spectra are mostly unchanged and the small intensity change can be ascribed to better crystallization. After annealing in vacuum, the sizes of SnO₂ NCs become larger and their surfaces are reconstructed. However, the OV content hardly changes with their morphology transformation.^[21] This verifies that OV_s play a crucial role in the *f*₁ and *f*₄ modes. In addition, a broad shoulder type band appears at ~440–450 cm⁻¹ in most of the Raman spectra. The shoulder band may arise from deeper OV_s inside SnO₂ NCs. When the sample is annealed in O₂, the NCs grow and the surface OV_s vanish easily, but the deeper internal OV_s still exist. When the annealing temperature reaches 1000 °C, OV_s decrease largely. This leads to the appearance of the shoulder band.^[22] For annealing treatment in vacuum, it only makes the SnO₂ NCs grow but does not largely eliminate OV_s (especially internal OV_s). As a result, the shoulder band hardly changes.

To further explore the origins of the *f*₁ and *f*₄ modes, DFT is adopted to calculate the Raman characteristics of SnO₂ structures with different types of OV_s along the (110) plane. With the use of the Broyden–Fletcher–Goldfarb–Shanno minimizer in the CASTEP package with default convergence tolerances of 1.0 × 10⁻⁵ eV for energy and 0.3 eV/nm for maximum displacement,^[9,13,23] the geometric structures of all the supercells are optimized to obtain stable structures as shown in the inset of Fig. 2. In our calculation, the norm-conserving pseudo-potential method is chosen together with the gradient correction and Perdew–Burke–Ernzerhof potential function.^[24] The calculated Raman spectra of the SnO₂ structures containing bridging, subbridging, and in-plane OV_s as well as without OV_s (*P*₁, *P*₃, *P*₂, and *P*, respectively in the inset of Fig. 2) are presented in Fig. 4(a). In the presence of in-plane OV_s, the *S*₃ mode at ~573.5 cm⁻¹ (line b) can be clearly observed. The existence of a bridging OV type (line c) causes the wavenumber of the *f*₄ mode to downshift, and a weak *f*₁ mode appears at the same time. Compared with the result of no OV, the subbridging OV_s hardly affect the position of mode *f*₄ but slightly change its intensity. Evidently, the behavior of the *f*₁, *S*₃, and *f*₄ modes is different from that of the sample without OV (line a), and it depends strongly on the OV types. According to the calculated Raman spectra shown in Fig. 4(b), the experimental results can be explained. Firstly, the combined action of subbridging and bridging OV_s not only effectively enhances the *f*₁ mode intensity but also downshifts the wavenumber of mode *f*₄ (line g), as consistent with the experimental

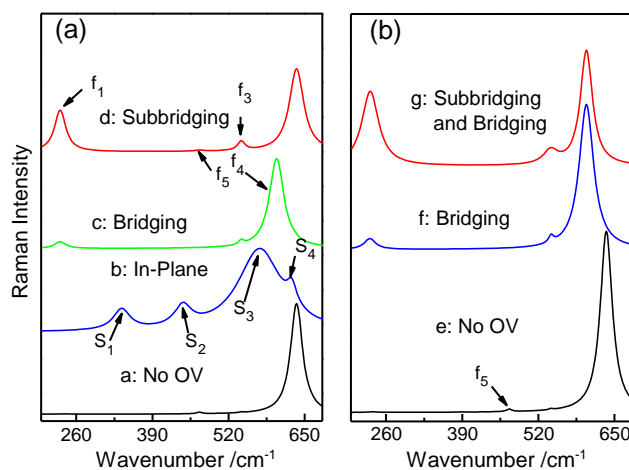


Figure 4. (a) Calculated Raman spectra with different OV types. (b) Calculated Raman spectra for comparison with the corresponding experimental Raman results.

results obtained from the *T*_a = 0 °C sample in Fig. 3(a). Annealing at *T*_a = 400 °C eliminates the subbridging OV_s on the NC surface. As a result, the intensity of mode *f*₁ diminishes abruptly, but the wavenumber only up-shifts slightly, whereas the intensity and wavenumber of mode *f*₄ do not vary. This implies that bridging OV_s still exist as verified by the calculated result (line f). Annealing at *T*_a = 600 °C removes the bridging OV_s. Mode *f*₄, which is affected by the bridging OV, returns to the position of the bulk mode. The residual weak peak at ~245.6 cm⁻¹ (*f*₁) (*T*_a = 600 and 800 °C) may be related to OV_s inside the NC. They can be completely eliminated at *T*_a = 1000 °C and approach those of the calculated Raman spectrum without OV_s (line e). The experimental and theoretical results indicate that the subbridging, bridging, and in-plane OV_s are responsible for the *f*₁, *f*₄, and *S*₃ modes, respectively. The small deviation between the calculated and experimental data may be due to the complex nature of the samples. In order to read conveniently the peak positions in Figs 2–4, we have listed various peak wavenumbers in Tables S2 and S3 (Supporting Information) for comparison.

Conclusion

In summary, the Raman spectra acquired from spherical SnO₂ NCs produced by pulsed laser ablation show that as the annealing temperature *T*_a increases, the 234.5 and 618 cm⁻¹ modes exhibit reduced intensity and location shift, respectively. Our DFT calculation reveals that the two modes depend strongly on the subbridging and bridging OV_s and the 573.5 cm⁻¹ mode arises from the in-plane OV_s.^[13] Our results demonstrate that Raman scattering can be used to identify the types of OV_s in SnO₂ nanostructures.

Acknowledgements

This work was jointly supported by Grants (Nos. 2011CB922102 and 60976063) from the National Natural Science Foundation and Basic Research Programs of China, and Postdoctoral Science Foundation of China and Jiangsu Province (Nos. 2011M500889 and 1102001B). Partial support was also from PAPD and Hong Kong Research Grants Council (RGC) General Research Fund (GRF) No. CityU 112510.

Supporting information

Supporting Information may be found in the online version of this article.

References

- [1] S. Brovelli, A. Chiodini, A. Lauria, F. Meinardi, A. Paleari, *Phys. Rev. B* **2006**, *73*, 073406.
- [2] C. Kilic, A. Zunger, *Phys. Rev. Lett.* **2002**, *88*, 095501.
- [3] S. O. Kucheyev, T. F. Baumann, P. A. Sterne, Y. M. Wang, T. Buuren, A. V. Hamza, L. J. Terminello, T. M. Willey, *Phys. Rev. B* **2005**, *72*, 035404.
- [4] Y. Idota, T. Kubota, A. Matsufuji, Y. Maekawa, T. Miyasaka, *Science* **1997**, *276*, 1395.
- [5] R. Asahi, T. Morijawa, T. Ohwaki, K. Aoki, Y. Taga, *Science*, **2001**, *293*, 269.
- [6] Y. J. Chen, L. Nie, X. Y. Xue, Y. G. Wang, T. H. Wang, *Appl. Phys. Lett.* **2006**, *88*, 083105.
- [7] L. Z. Liu, X. X. Li, X. L. Wu, X. T. Chen, P. K. Chu, *Appl. Phys. Lett.* **2011**, *98*, 133102.
- [8] J. Q. Hu, Y. Bando, Q. L. Liu, D. Golberg, *Adv. Funct. Mater.* **2003**, *13*, 493.
- [9] H. T. Chen, S. J. Xiong, X. L. Wu, J. Zhu, J. C. Shen, P. K. Chu, *Nano Lett.* **2009**, *9*, 1926.
- [10] E. J. H. Lee, C. Ribeiro, T. R. Giraldo, E. Longo, E. R. Leite, J. A. Varela, *Appl. Phys. Lett.* **2004**, *84*, 1745.
- [11] L. H. Jiang, G. Q. Sun, Z. H. Zhou, S. G. Sun, Q. Wang, S. Y. Yan, H. Q. Li, J. Tian, J. S. Guo, B. Zhou, Q. Xin, *J. Phys. Chem. B* **2005**, *109*, 8774.
- [12] M. A. Mäki-Jaskari, T. T. Rantal, *Phys. Rev. B* **2002**, *65*, 245428.
- [13] L. Z. Liu, X. L. Wu, F. Gao, J. C. Shen, T. H. Li, P. K. Chu, *Solid State Commun.* **2011**, *151*, 811.
- [14] T. Hirata, K. Ishioka, M. Kitajima, H. Doi, *Phys. Rev. B* **1996**, *53*, 8442.
- [15] T. H. Li, L. Z. Liu, X. L. Wu, J. C. Shen, F. Gao, P. K. Chu, *Appl. Phys. Lett.* **2010**, *97*, 121901.
- [16] J. Zou, C. Y. Xu, X. M. Liu, C. S. Wang, C. Y. Wang, Y. Hu, Y. T. Qian, *J. Appl. Phys.* **1994**, *75*, 1835.
- [17] L. Abello, B. Bochu, A. Gaskov, S. Koudryavtseva, G. Lucazeau, M. Roumyantseva, *J. Solid State Chem.* **1998**, *135*, 78.
- [18] A. Diéguez, A. Romano-Rodríguez, A. Vilà, J. R. Morante, *J. Appl. Phys.* **2001**, *90*, 1550.
- [19] L. Z. Liu, X. L. Wu, Z. Y. Zhang, T. H. Li, P. K. Chu, *Appl. Phys. Lett.* **2009**, *95*, 093109.
- [20] I. H. Campbell, P. M. Fauchet, *Solid State Commun.* **1986**, *58*, 739.
- [21] T. H. Li, L. Z. Liu, X. X. Li, X. L. Wu, H. T. Chen, P. K. Chu, *Opt. Lett.* **2011**, *36*, 4296.
- [22] K. N. Yu, Y. H. Xiong, Y. L. Liu, C. S. Xiong, *Phys. Rev. B* **1997**, *55*, 2666.
- [23] L. Z. Liu, X. L. Wu, J. C. Shen, T. H. Li, F. Gao, P. K. Chu, *Chem. Comm.* **2010**, *46*, 5539.
- [24] B. G. Pfrommer, M. Cote, S. G. Louie, M. L. J. Cohen, *J. Comput. Phys.* **1997**, *131*, 233.

Supporting Information

Identification of Oxygen Vacancy Types from Raman Spectra of SnO₂ Nanocrystals

L. Z. Liu, T. H. Li, X. L. Wu, J. C. Shen, and Paul K. Chu

Table S1. The comparison for preparation conditions between pulsed laser ablation and hydrothermal synthesis methods

Method	Preparation condition
Hydrothermal synthesis	Reactant: NH ₃ ·H ₂ O and SnCl ₄ ·5H ₂ O Condition: pH=7 Temperature: 200°C
Pulsed laser ablation	Reactant: Sn target and H ₂ O Laser power: 250 mJ/pulse Laser wavelength: 248 nm

Table S2. Peak positions in the experimental Raman spectra of Figure 2 and comparison with the calculated results of Figure 4

Peak	Mode	Shift (cm ⁻¹)	
		Experimental	Calculated
S ₁	E _u	353.5	337.7
S ₂	E _g	430.5	—
S ₃	(In-Plane OV)	573.5	573.5
S ₄	A _{1g}	630.0	627.2

The sample is prepared by hydrothermal synthesis method, and peak S₃ originates from in-plane oxygen vacancies.

Table S3. Peak positions in the experimental Raman spectra of Figure 3 at different annealing temperatures, $T_a = 0, 400, 600, 800, 1000^\circ\text{C}$, and comparison with the calculated results of Figure 4

		Shift (cm^{-1})											
Peak	Mode	$T_a=0^\circ\text{C}$		$T_a=400^\circ\text{C}$		$T_a=600^\circ\text{C}$		$T_a = 800^\circ\text{C}$		$T_a = 1000^\circ\text{C}$		Calculated	
		Oxygen	Vacuum	Oxygen	Vacuum	Oxygen	Vacuum	Oxygen	Vacuum	Oxygen	Vacuum	OV	no OV
f ₁	E _u	234.5	234.5	245.6	234.5	245.6	234.5	245.6	234.5	—	234.5	232.8	—
f ₂	E _g	498.5	498.5	498.5	498.5	499.3	498.5	499.3	498.5	499.3	498.5	—	—
f ₃	B _{1u(3)}	540.5	540.5	540.5	540.5	540.5	540.5	540.5	540.5	540.5	540.5	543.5	543.5
f ₄	A _{1g}	619.5	619.5	619.8	619.5	630.4	619.5	631.2	619.5	633.2	619.5	602.9	627.2
f ₅	B _{1u(2)}	—	—	—	—	475.5	—	475.5	—	—	475.5	475.5	475.5

The samples are prepared by pulsed laser ablation, and peaks f₁ and f₄ are affected by subbridging and bridging oxygen vacancies, respectively.